

Exercises: Particle Detectors WS 2016/17
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Problem Set No. 6

**Solutions have to be handed in by Wednesday 3pm, 30.11.2016 in letter box
no. 3, in the ground floor of Gustav-Mie building!**

1. **pn-junction**

- Sketch the behaviour of capacitance $C(U)$ as a function of the applied voltage U of a diode operated in reverse mode.
- Calculate the diffusion voltage and the width of the depletion zone of a diode. It is assumed to be doped with $N_A = 10^{17} \text{ cm}^{-3}$ and $N_D = 10^{16} \text{ cm}^{-3}$ at $T=300 \text{ K}$, assume $n_i = 15 \times 10^{10} \text{ cm}^{-3}$.
- How much does the depletion zone penetrate in both doped areas of the diode at a applied bias voltage of 5 V ? (In case you couldn't solve bullet two, use for the diffusion voltage 0.7 V .)

[3 points]

2. **Silicon detector**

A silicon detector with a surface area of 100 mm^2 and $300 \mu\text{m}$ thickness is used to detect and trigger on minimum ionizing particles (MIPs) crossing at a roughly perpendicular angle. The detector is asymmetrically doped with a thin p-layer and a doping level of $6.6 \times 10^{12} \text{ cm}^{-3}$ in the n-bulk. The signal is read out over a voltage amplifier, with a time constant sufficiently large that the detector current pulse is integrated on the detector capacitance and the resulting voltage pulse is sensed by the amplifier.

- What is the required bias voltage to fully deplete the detector?
- The detector is operated well beyond full depletion. What is the collection time and the 10-90% rise time of the voltage pulse? For simplicity assume saturation of drift velocities, using $9 \times 10^6 \text{ cm/s}$ for electrons and $5 \times 10^6 \text{ cm/s}$ for holes.
- What is the peak voltage signal and 10-90% rise time for an otherwise identical detector operated the same way, but with a thickness of $100 \mu\text{m}$?
- A MIP loses $\approx 80 \text{ keV}$ of energy in the $300 \mu\text{m}$ of silicon. Given that 3.6 eV are required to produce an electron/hole pair and the relative permittivity $\epsilon_{Si} = 11.9$, what is the peak voltage of the signal at the amplifier input?

[6 points]

3. **Leakage current**

In addition to the recombination lifetime an important parameter of semiconductor detector material is the charge generation lifetime τ_g . As electrons and holes are created in pairs the equilibrium condition is $p = n = n_i$. The lifetime τ_g can be expressed as $\tau_g = n_i / G_{th}$, using the thermal generation rate G_{th} . The leakage current results as $I = e \times A \times W_D \times G_{th}$, with A being the detector area and W_D the depletion width.

- At room temperature $n_i \approx 10^{10} \text{ cm}^{-3}$. What is the leakage current per cm^3 in a fully depleted silicon detector for $\tau_g = 1 \text{ ms}$?
- What is the leakage current after an equivalent particle fluence $\phi_{eq} = 10^{14} \text{ cm}^{-2}$, with the proportionality constant α being $2 \times 10^{-17} \text{ A/cm}$?

[3 points]